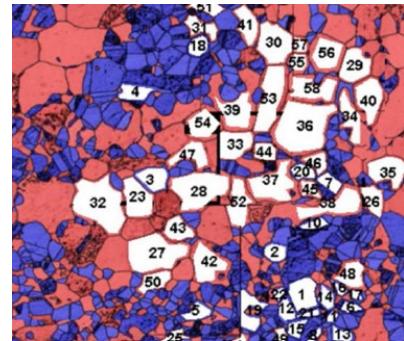
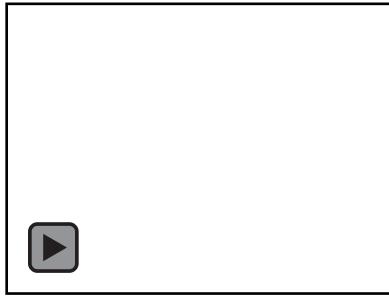


Workshop on Sachsen-DESY-Kooperationszentrum



DESY NanoLab

Andreas Stierle

Centre for X-Ray and Nanoscience (CXNS), DESY

NanoLab@DESY: Centre for X-Ray and Nanoscience



 HELMHOLTZ
ASSOCIATION

Science City Hamburg Bahrenfeld (SCHB)



The DESY NanoLab

Providing on-site methods for nanoscience complementary to DESY photon science techniques at PETRA III(IV) and FLASH



Open for:

- External users in the framework of accepted proposals or “around” X-ray beamtimes <https://door.desy.de>
- Support of DESY in-house research (collaborative / contributive level)
- European users in the framework of the access program Nanoscience Foundries and Fine Analysis <https://www.nffa.eu/>
- Industrial users (DESY ITT + NFFA)



How to Access the DESY NanoLab

During online PETRA III/FLASH proposal submission via DOOR

| | |
|---|---|
| Open cycle flow cryostat (4-300K) | <input type="radio"/> Yes <input checked="" type="radio"/> No |
| Polarization | <input checked="" type="checkbox"/> standard <input type="checkbox"/> variable linear <input type="checkbox"/> circular |
| Polarization analyzer | <input type="radio"/> Yes <input checked="" type="radio"/> No |
| DESY NANOLAB (CONSULT DESY NANOLAB INSTRUMENTATION PAGE) | |
| Access to DESY NanoLab | Yes |
| Brief description of planned activities | |
| Microscopy: AFM (air) | No |
| Microscopy: Dual-beam focused ion beam (FIB) | No |
| Microscopy: High-resolution scanning electron microscope (SEM) | No |
| Microscopy: Variable temperature UHV STM/AFM | No |
| Surface spectroscopy: UHV-reflection absorption IR spectroscopy | Yes |
| Surface spectroscopy: X-ray photoelectron spectroscopy (XPS) | No |
| UHV Sample preparation | No |
| X-ray diffraction: Reflectometer | No |
| X-ray diffraction: Six-circle diffractometer | No |

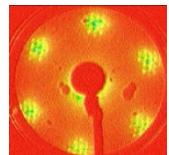
MAIN

SAVE & CONTINUE

nanolab@desy.de

Spectroscopy & Growth (H. Noei)

- UHV sample preparation chambers with LEED / AES
- XPS, FT-IR, STM, MBE growth



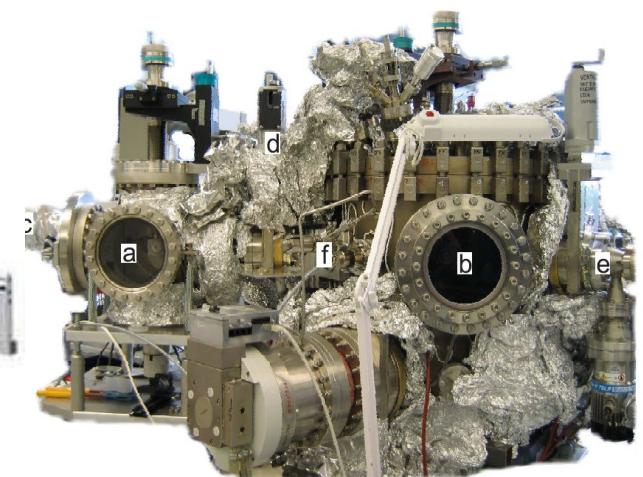
X-ray diffraction (V. Vonk)

- Reflectometer
- Six circle diffractometer
- Sample environments (het. catalysis, heating, UHV, electrochemistry)



Microscopy & Structuring (T. Keller)

- AFM, STM, optical
- SEM + FIB + EBSD + EDX (tomography)
- Lithography (CHyN)
- Scanning Auger Electron Microscope



Electrochemistry (M. Kohantorabi)

- Dedicated chemistry lab
- Potentiostats
- Induction oven / gases
- Solid / liquid FT-IR (FAU Erlangen)

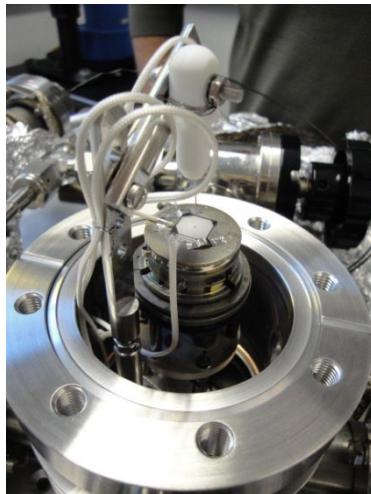
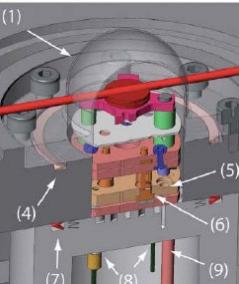
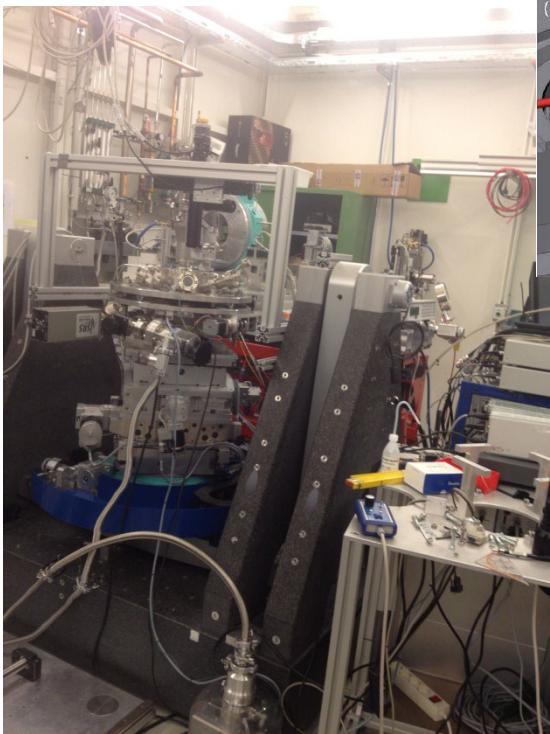
Magnetic Characterization (L. Bocklage)

- Physical properties measurement system
- Kerr Microscope

nanolab.desy.de

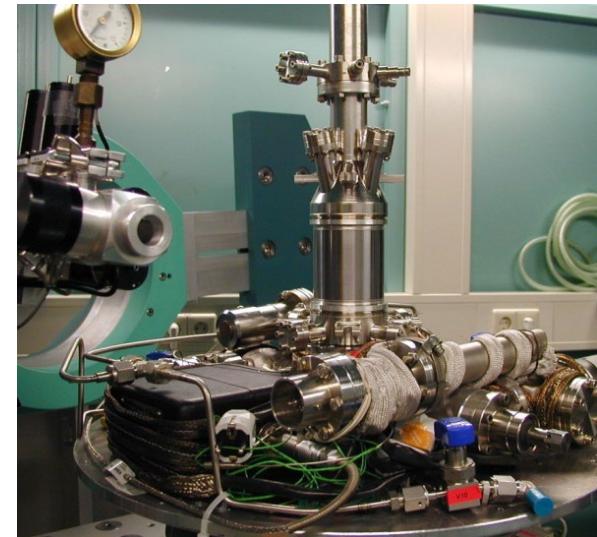
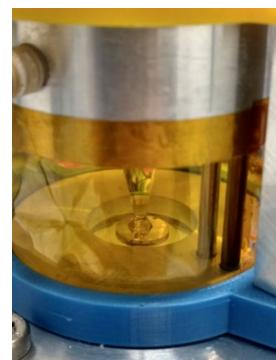
X-Rays: In-situ and Operando Experiments

Mobile in-situ X-ray Diffraction Sample Environments



In-situ UHV / flow reaction chamber for catalysis

In-situ solid state electrochemistry Chamber, EC cells, RDE



In-situ UHV / HP chambers
RT-900 K
UHV - 1 bar
RT- 1500 K
UHV – 10^{-4} mbar

X-Rays: In-situ and Operando Experiments

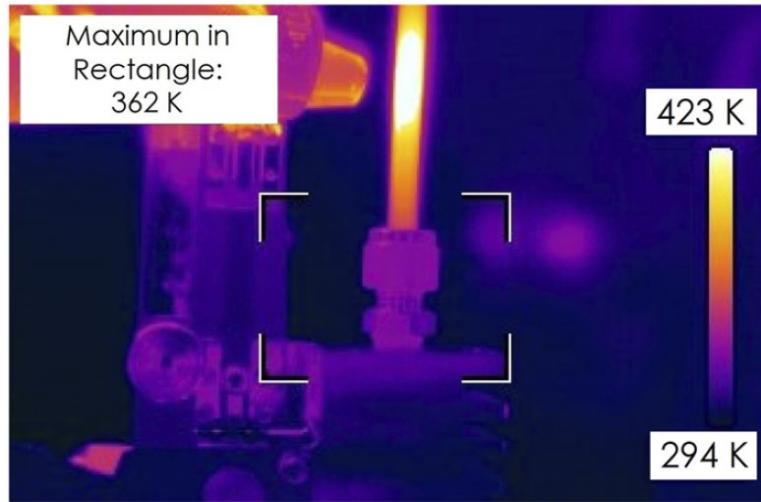
RESEARCH ARTICLE | JULY 06 2022

Operando reaction cell for high energy surface sensitive x-ray diffraction and reflectometry

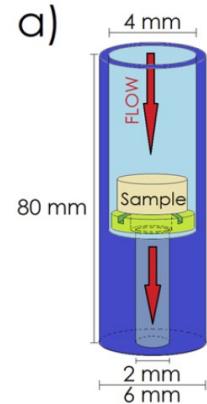
R. Gleißner; E. E. Beck; Simon Chung; ... et. al



Rev Sci Instrum 93, 073902 (2022)
<https://doi.org/10.1063/5.0098893>



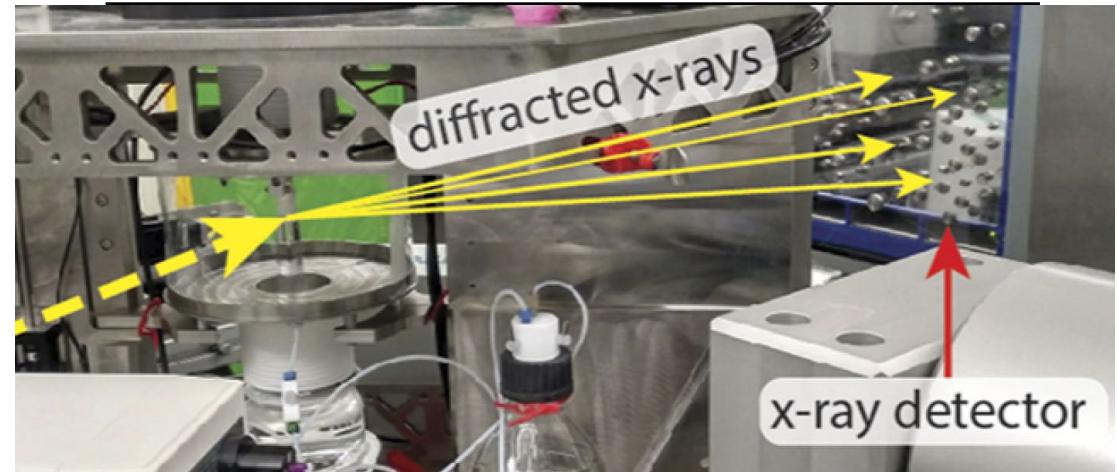
Catalysis SXRD flow cell
RT-700 K
50 bar



A combined rotating disk electrode–surface x-ray diffraction setup for surface structure characterization in electrocatalysis

Cite as: Rev. Sci. Instrum. 93, 065111 (2022); <https://doi.org/10.1063/5.0087864>
Submitted: 10 February 2022 • Accepted: 22 May 2022 • Published Online: 22 June 2022

Leon Jacobse, Ralf Schuster, Johannes Pfrommer, et al.

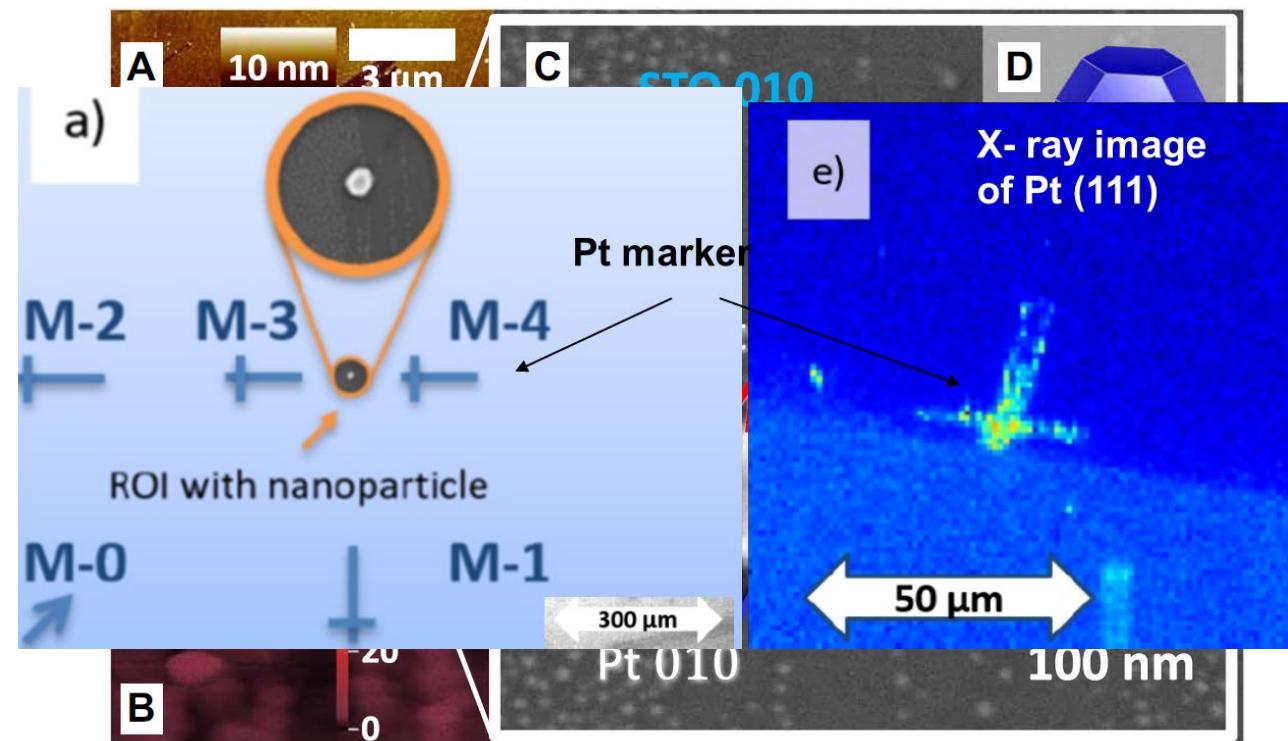
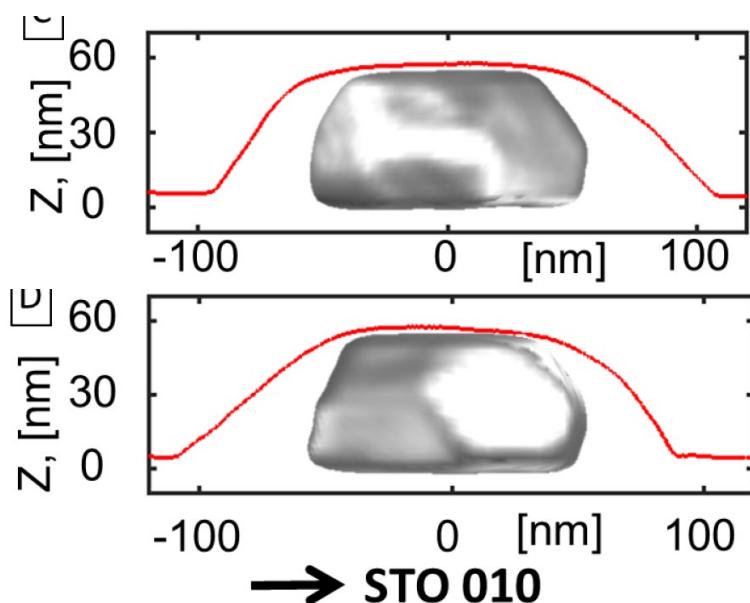


Combined setup for SXRD and FT-IRRAS under EC conditions
Collaboration with Libuda group (FAU), in preparation

X-ray Imaging of Selected Single Nanoparticles for Het. Catalysis

Sample preparation

- SrTiO₃(001) substrate (TiO₂ terminated)
- Pt and Rh codeposition at 1100 K
- Post growth annealing at 1473 K
- Composition: 60% Pt 40% Rh
- Nano particle preselection by SEM and AFM
- Pt marker deposition

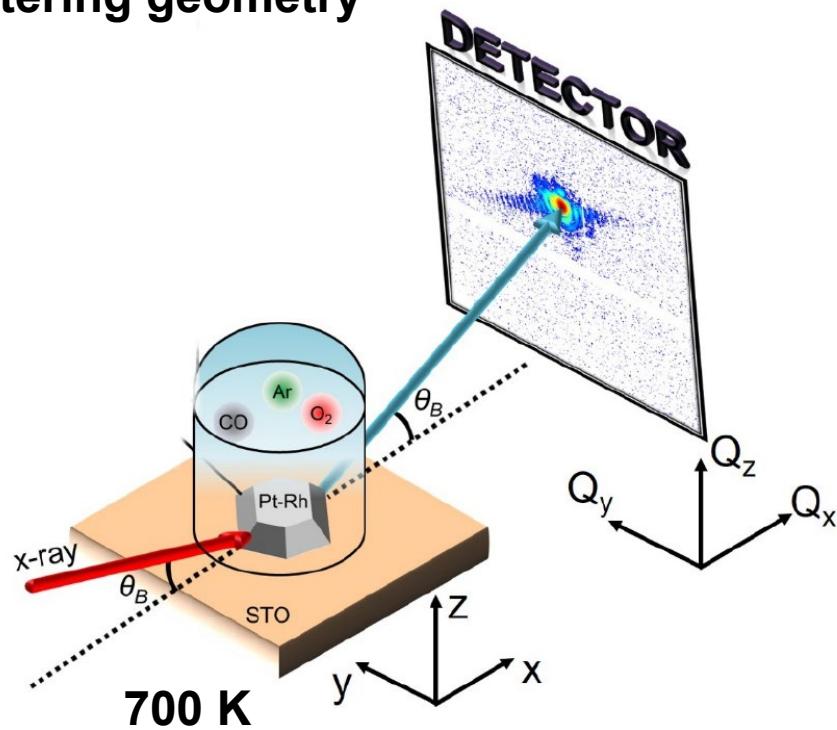


Nanoparticle height ~ 50 nm
diameter ~ 100 nm

Y. Y. Kim, T. F. Keller, T. J. Gonvalves, M. Abuin, H. Runge, L. Gelisio,
J. Carnis, V. Vonk, P. N. Plessow,
I. A. Vartanians, A. Stierle, *Science Advances*, Vol 7, 40 (2021)

Bragg Coherent Diffraction Imaging

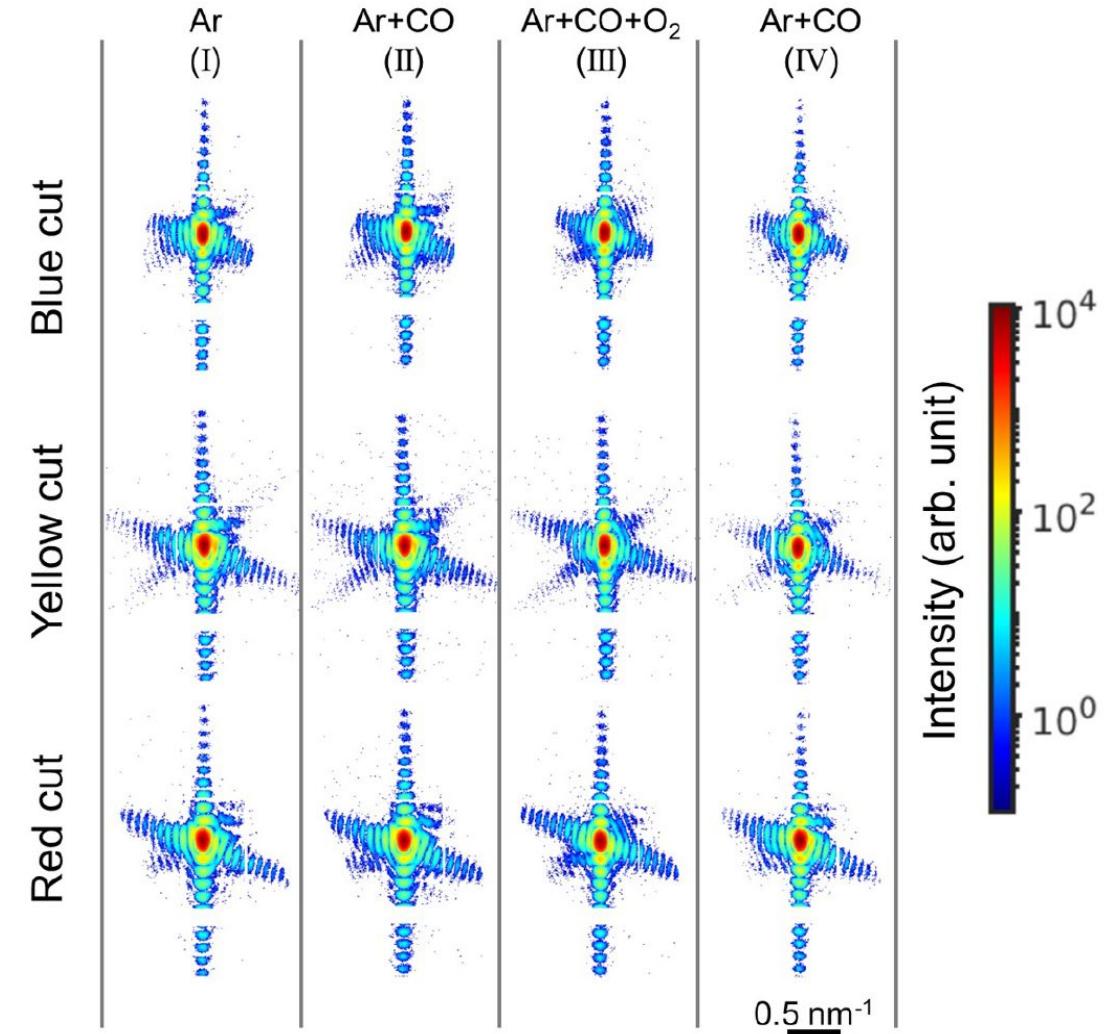
Scattering geometry



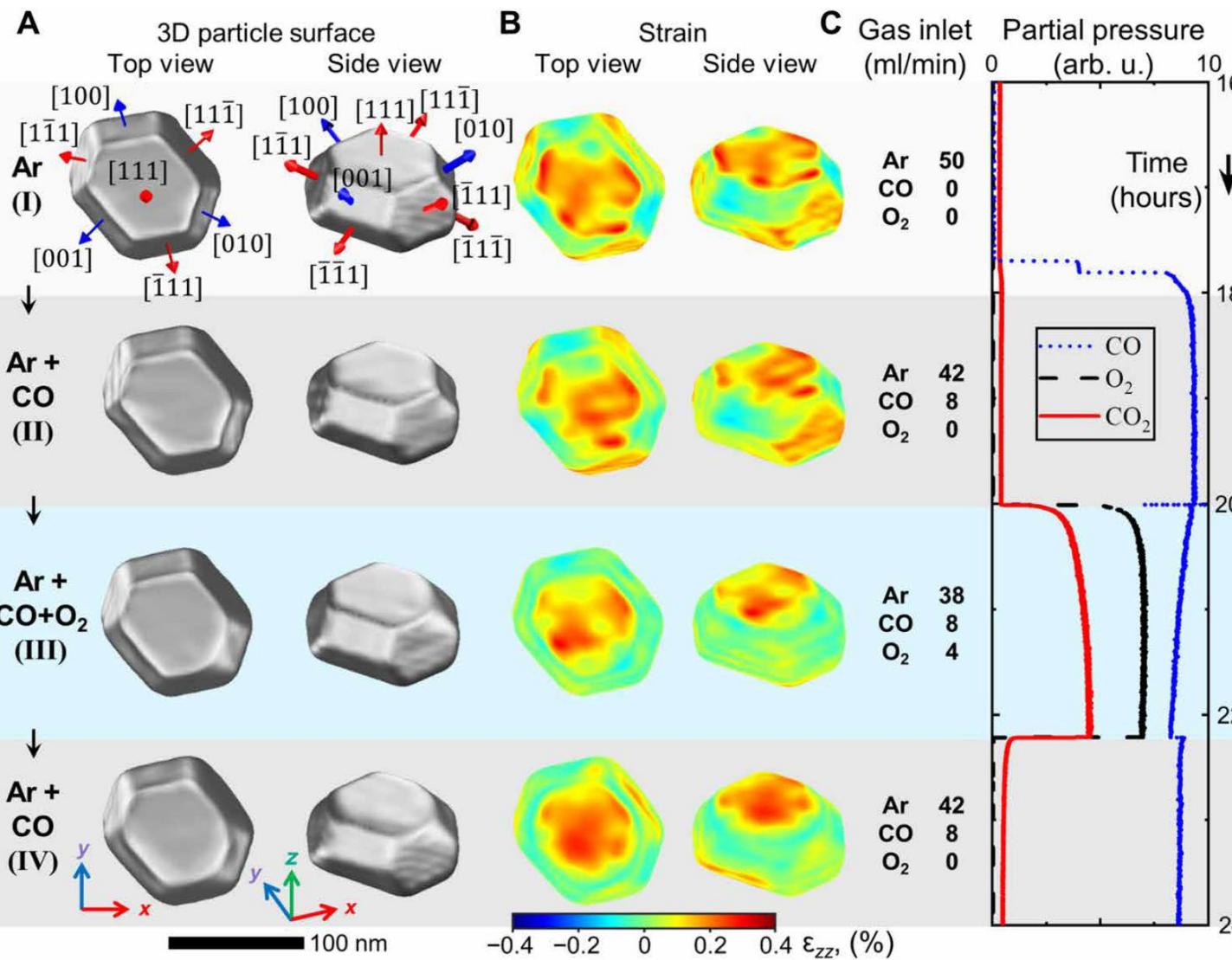
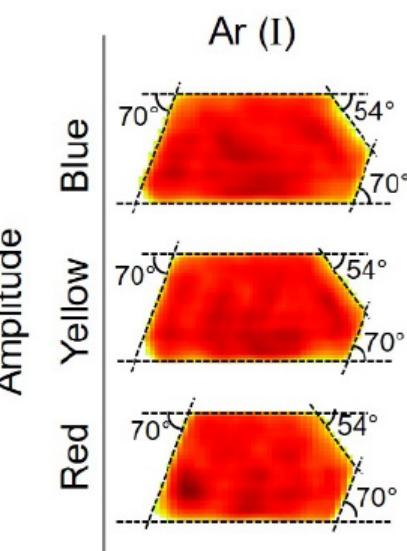
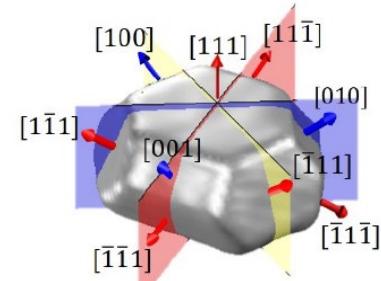
θ rocking scans: $\pm 1^\circ$
around the Pt (111) reflection

ESRF, ID01

Evolution of the diffraction signal



Amplitude and Strain Reconstruction by Phase Retrieval Algorithms



55 nm high, 95 nm wide, and 120 nm long

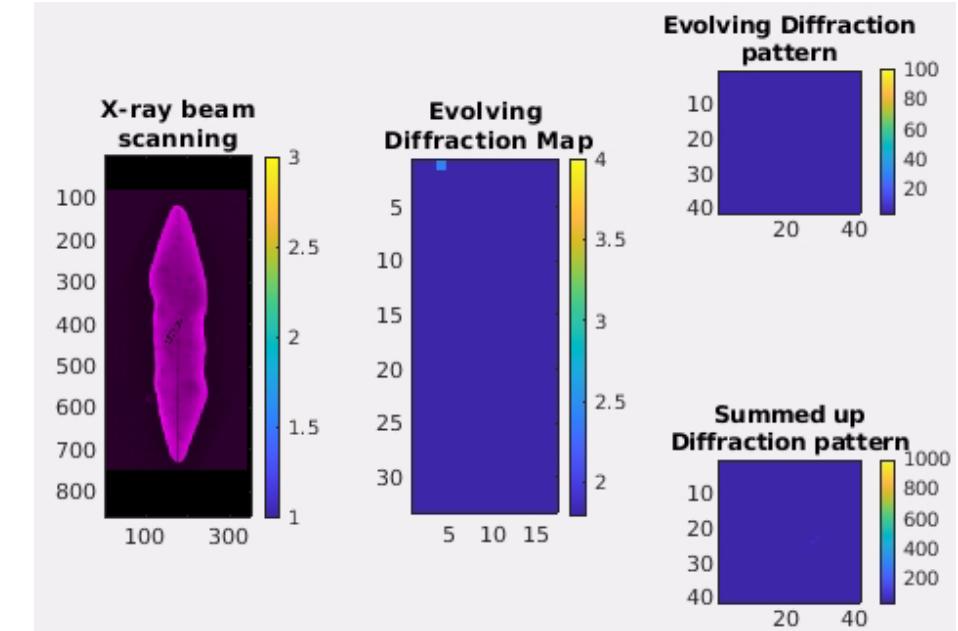
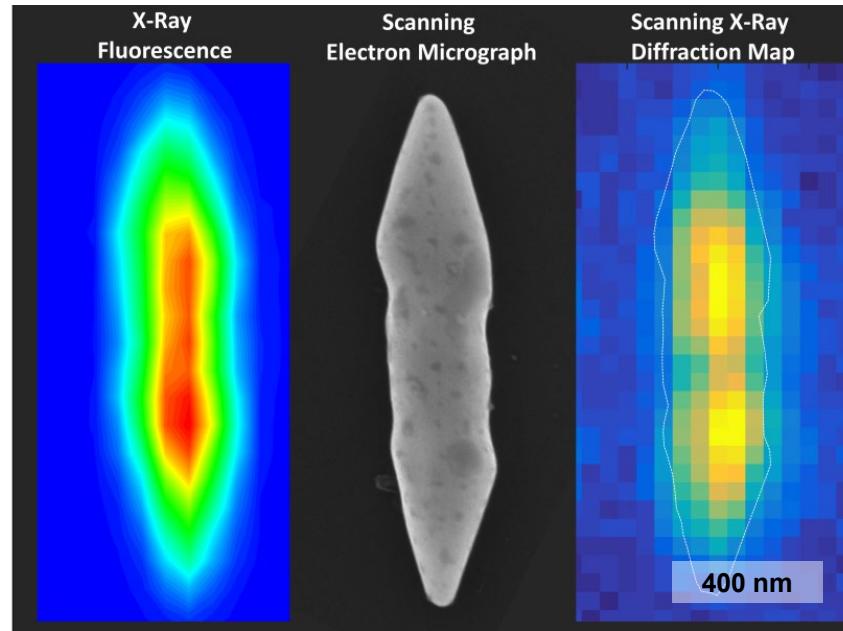
Positive strain more pronounced on <111> Type facets

More equal strain distribution on side facets

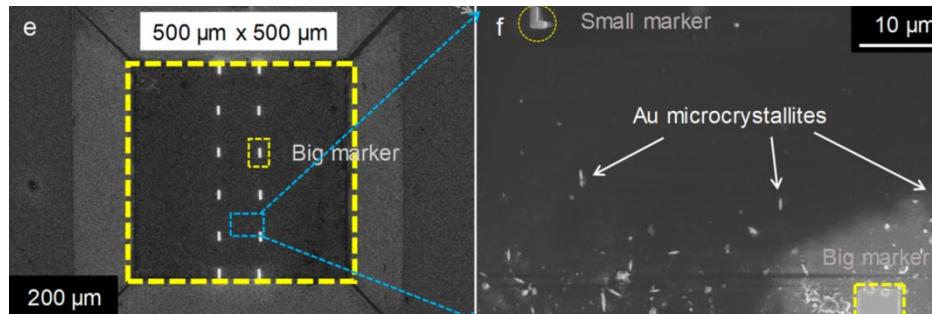
Change in strain state not reversible when back to pure CO

Multimodal Scanning X-ray Diffraction Microscopy

Spatial Distribution of Catalytic Non-Cubic Au in a Bipyramid Crystal at P06

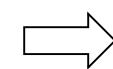


Courtesy of A. Sarma



MULTIMODAL MICROSCOPY

- X-ray Diffraction and Fluorescence
- Hierarchical markers
- One-to-one (SEM @ DESY NanoLab)



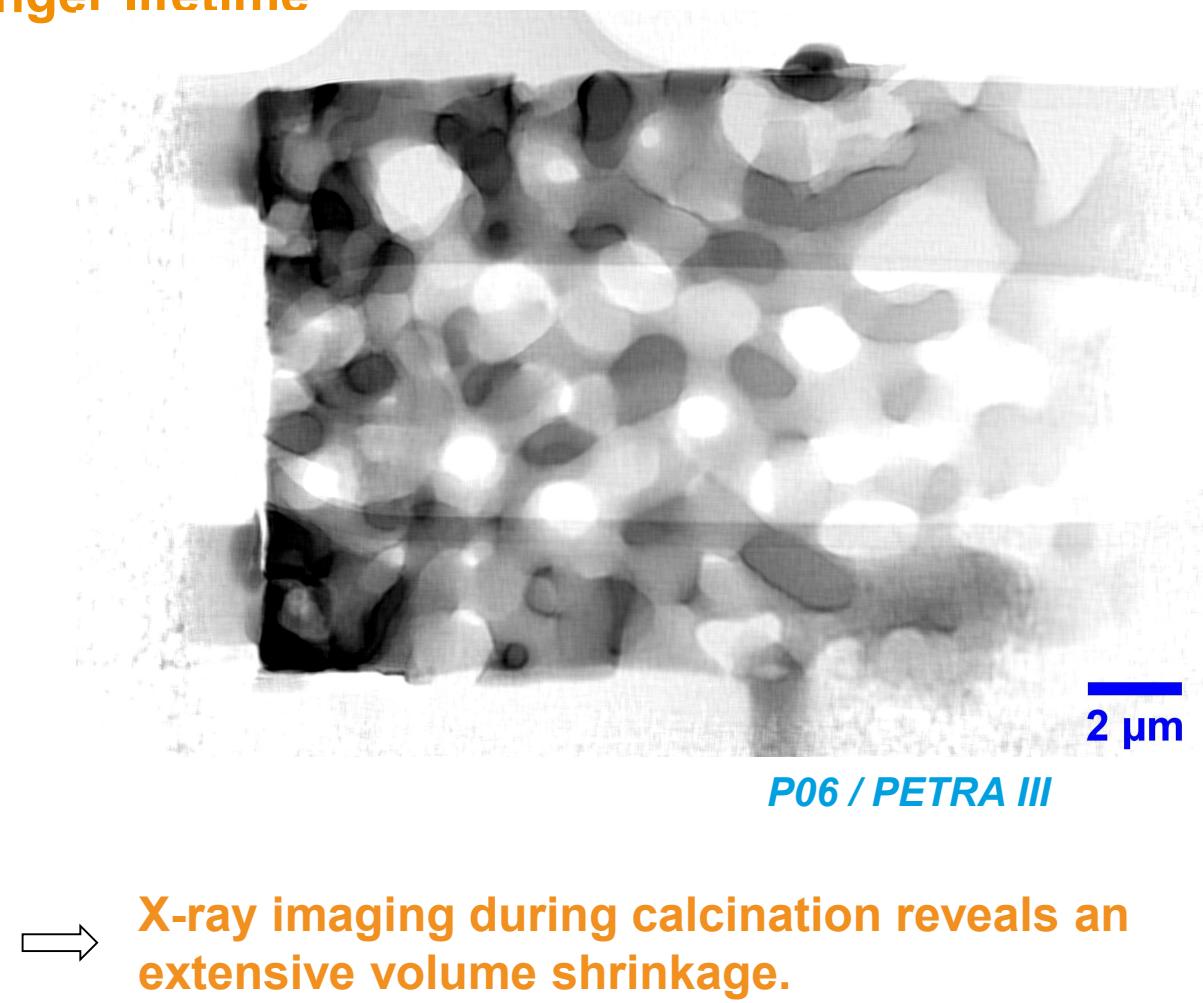
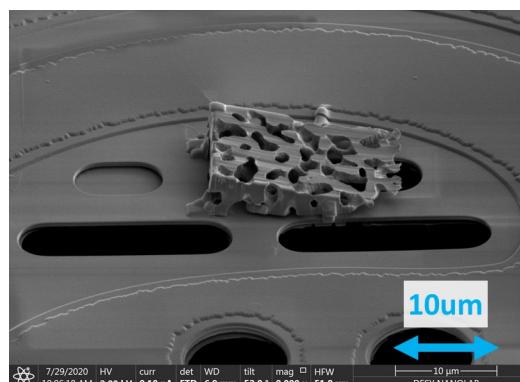
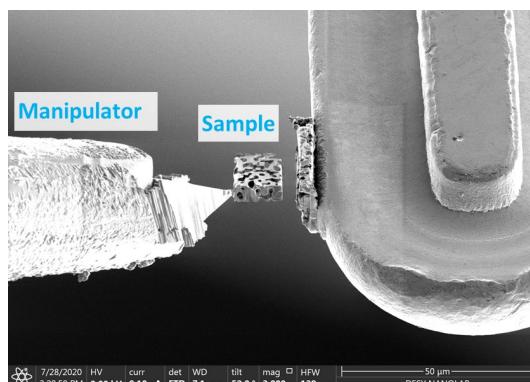
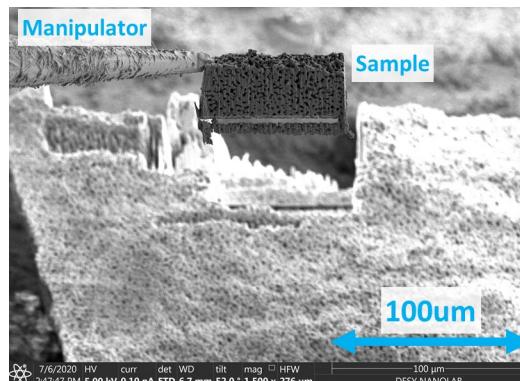
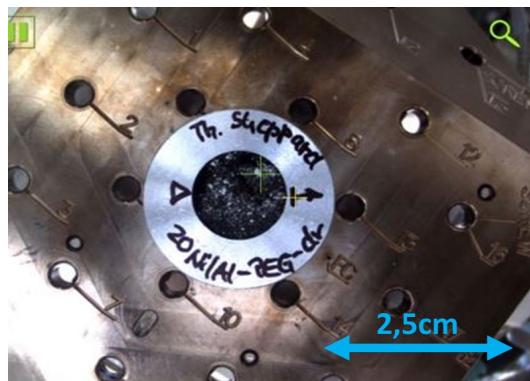


Live View into Catalyst Materials

For more efficient, selective catalysts with longer lifetime

30 °C - 600 °C

Hierarchical Nickel–Alumina catalysts
for CO₂ methanation reaction



X-ray imaging during calcination reveals an extensive volume shrinkage.

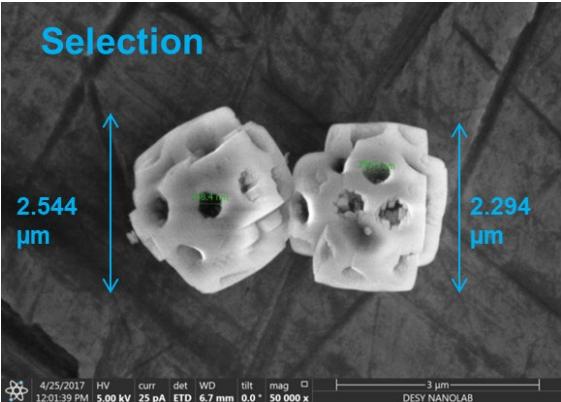
Collaboration within SFB 1441 "tracking the active site" coordinated by KIT

S. Weber et al., Advanced Science 2022, 2105432.

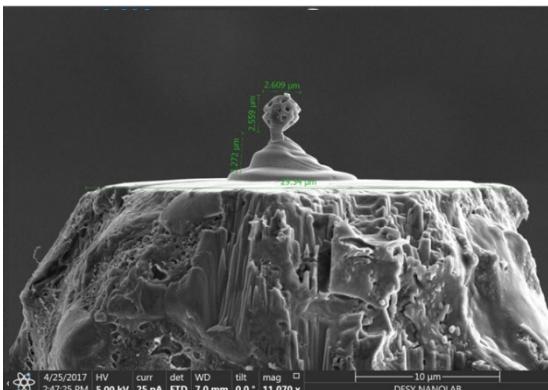
Combination of DESY NanoLab and PETRA III(IV)

Imaging a microporous zeolite carrier for catalytic nanoparticles

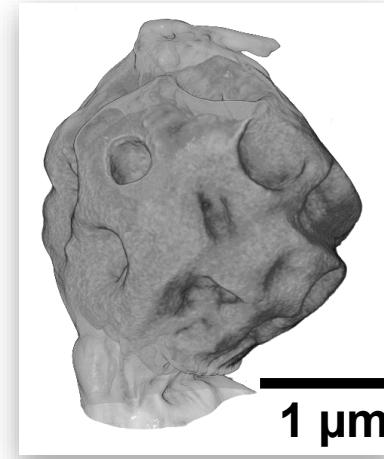
1. Selection in FIB / SEM



2. Mounting on tomography tip



3. 3D Ptycho- tomography + fluorescence (P06)



3D animation of reconstruction of zeolite, P06 ptycho-tomography

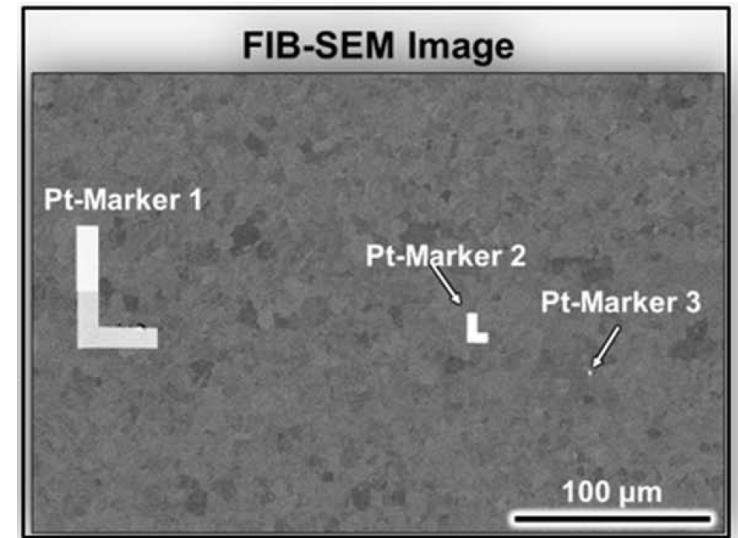
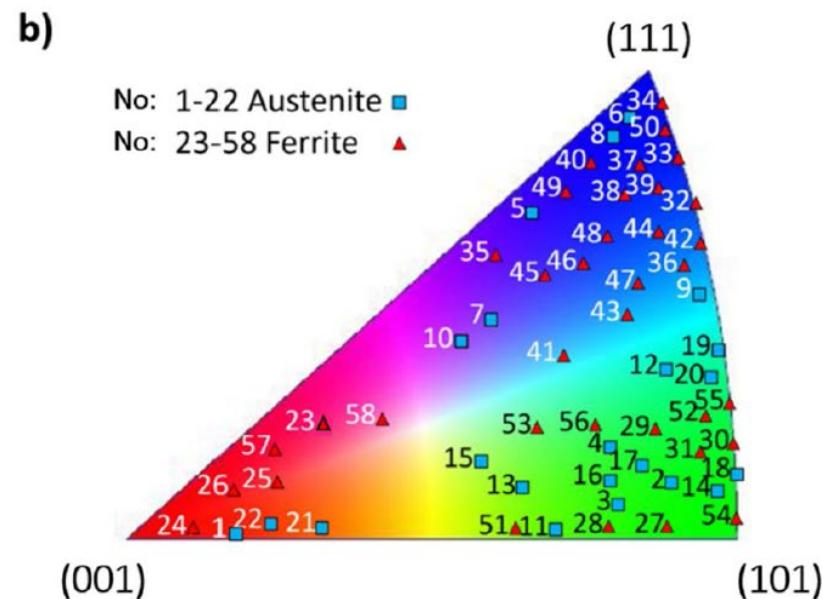
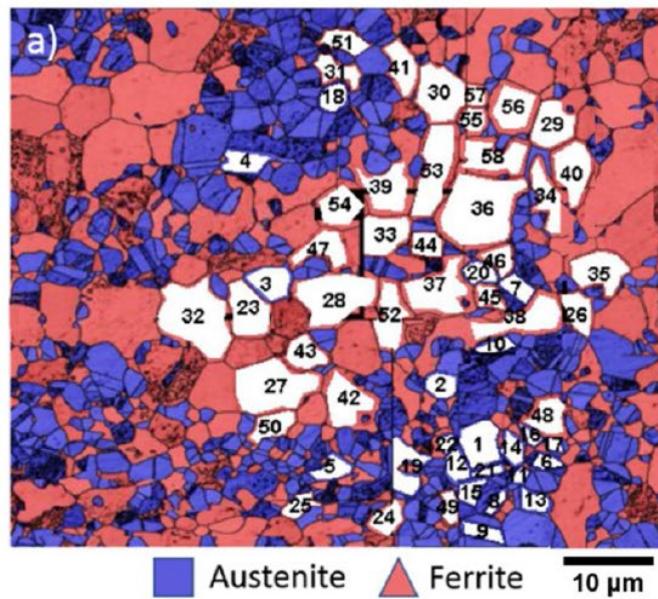
4. Post experimental FIB/SEM slice and view tomography

M. Seyrich, M. Kahnt, A. Schropp, C. Schroer,
DESY
S. Kulkarni, T. F. Keller, A. Stierle, DESY
T. Sheppard, J.-D. Grunwaldt, KIT

Combination of DESY NanoLab and PETRA III

Characterization of Native Oxide & Passive Film in Duplex Stainless Steel

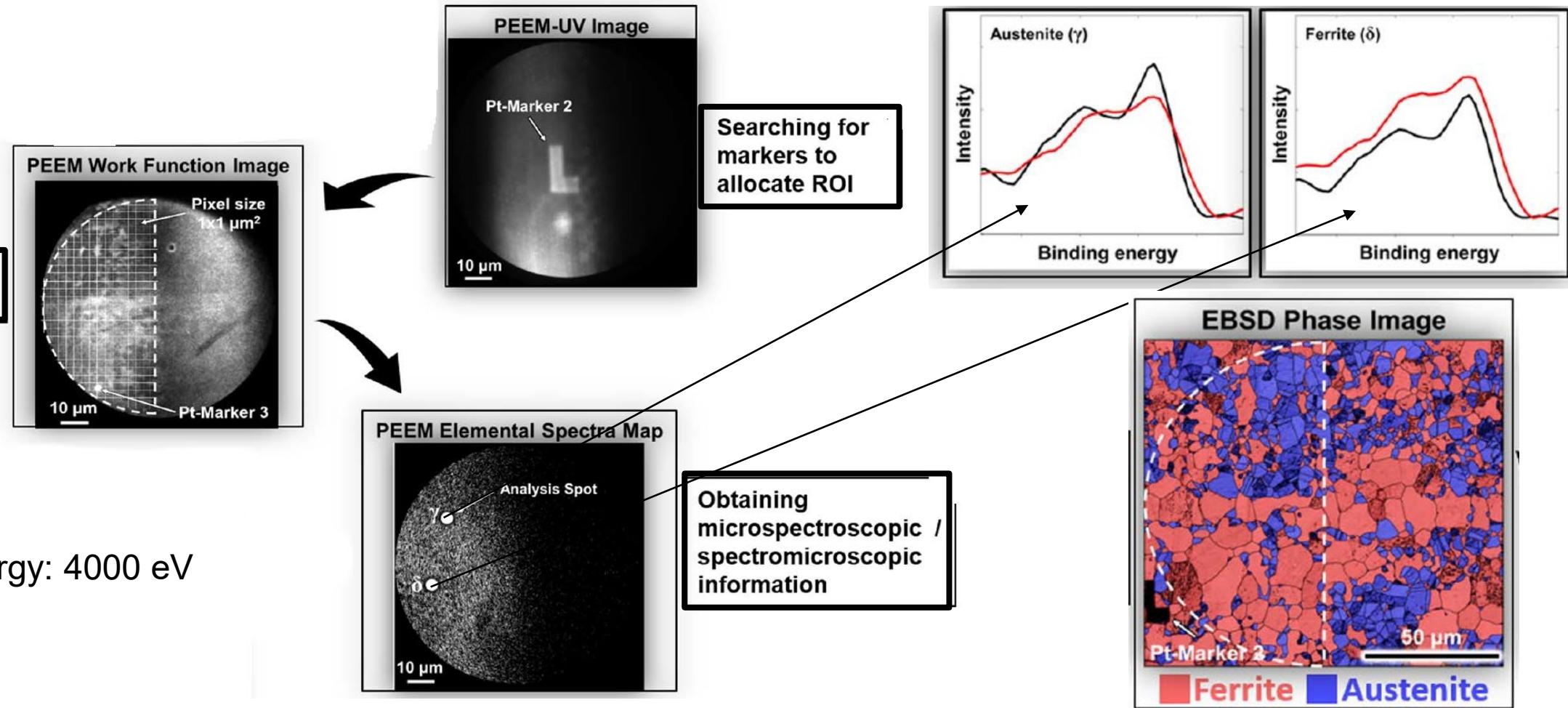
Duplex stainless steel: high corrosion resistance combined with high mechanical strength
ferrite (more Fe, Cr and Mo) and austenite phase (enriched in N and Ni)



DESY NanoLab: Electron Backscatter Diffraction (EBSD): phase and grain orientation determination
Pt marker deposition from Pt containing precursor

Combination of DESY NanoLab and PETRA III

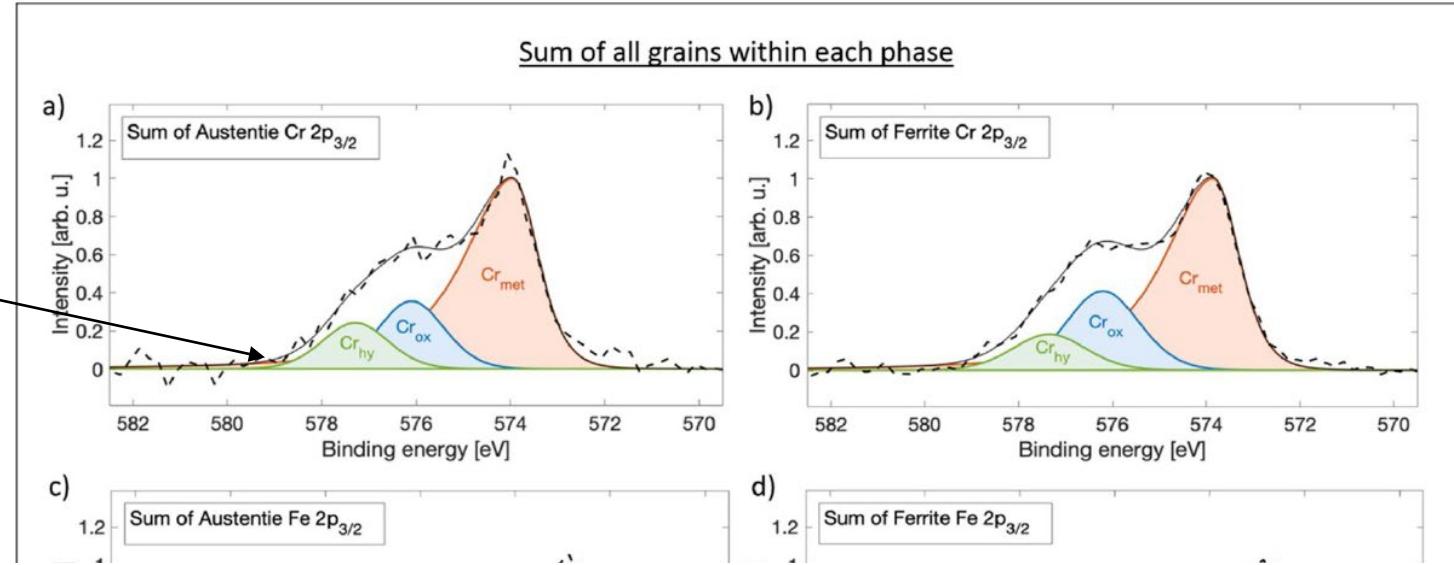
Hard X-ray photoelectron microscopy (HAXPEEM) at P22 (Hard X-ray photoemission beamline at PETRA III)



Combination of DESY NanoLab and PETRA III

Phase and orientation dependent natural oxide characterization on duplex stainless steel

more Cr hydroxide



Thickness (nm)

Inner layer

Outer layer

Total

Cr content (at%)

Inner layer

Outer layer

Average

Austenite

1.0

0.8

1.8

66

84

75

Ferrite

1.0

0.6

1.6

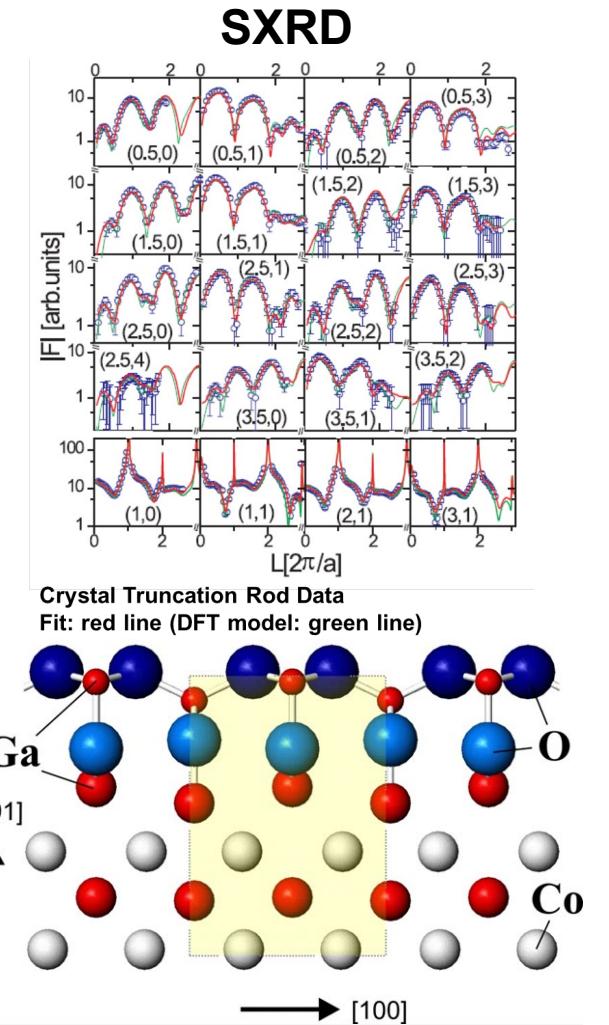
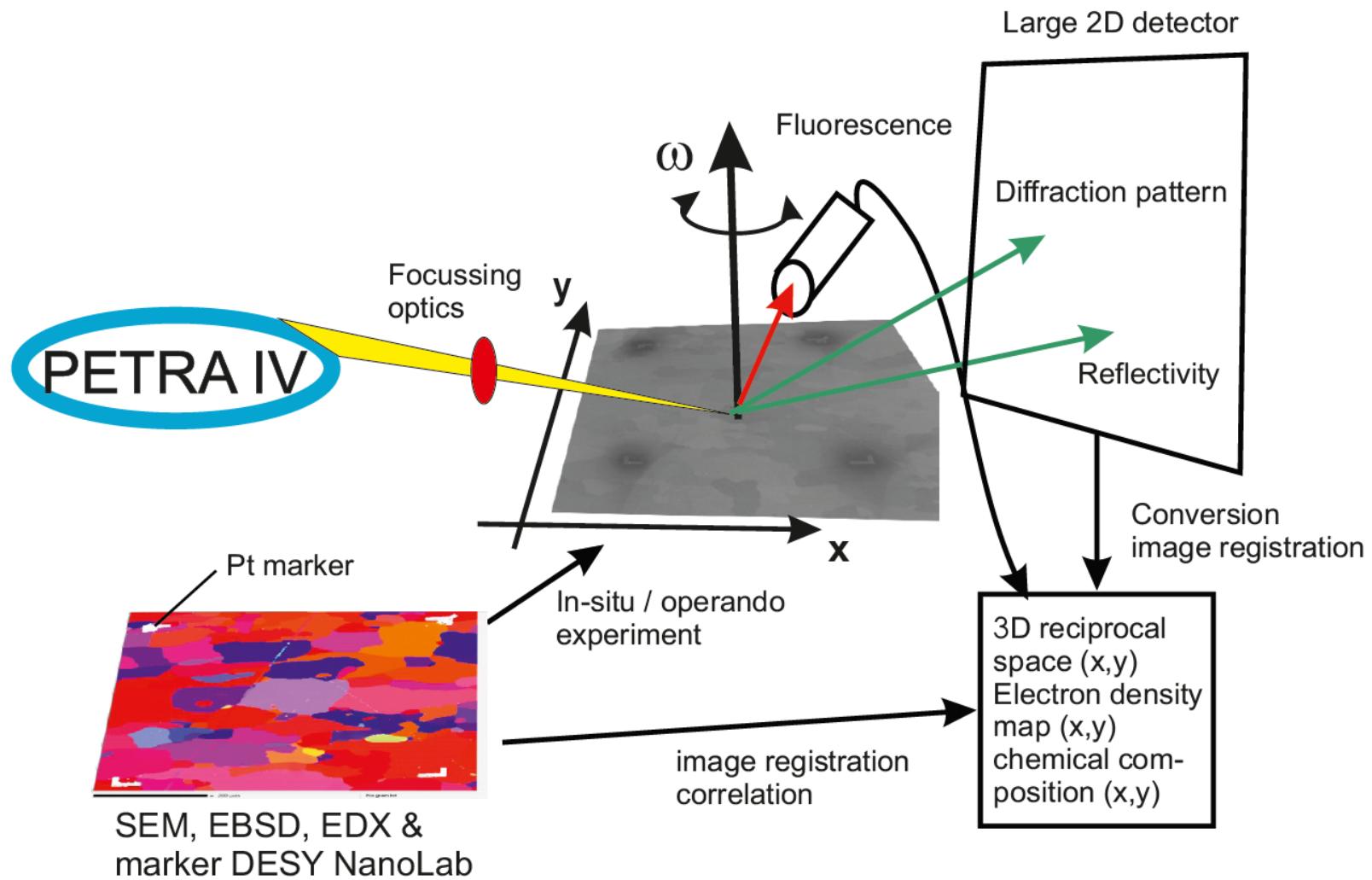
75

83

79

The Future: Surface Sensitive X-ray Diffraction with nm Resolution

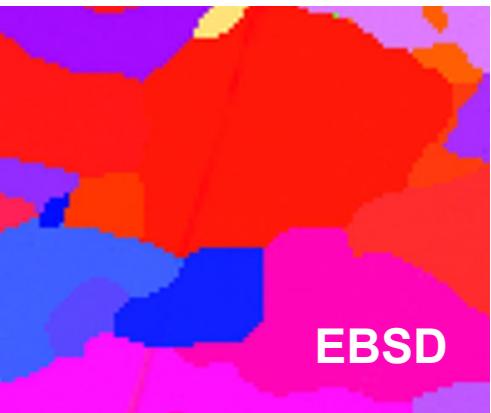
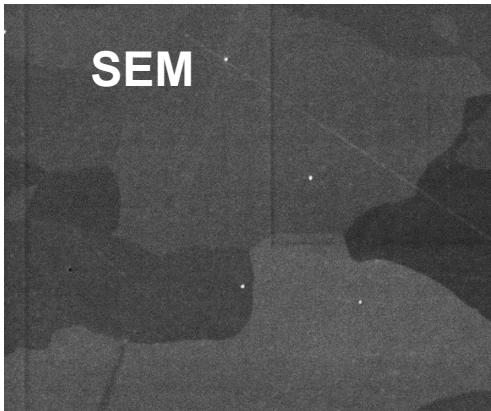
Fully automatized in-situ and operando experiments



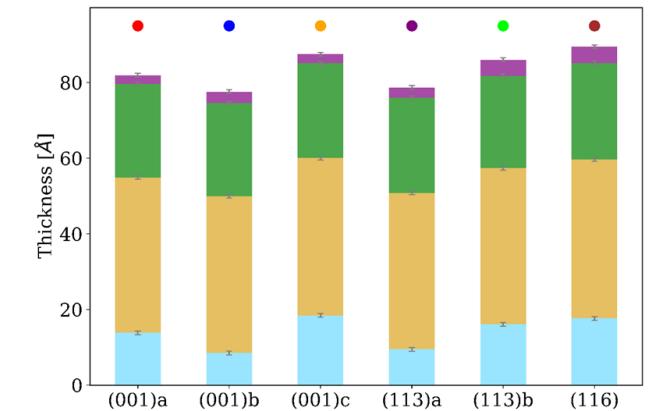
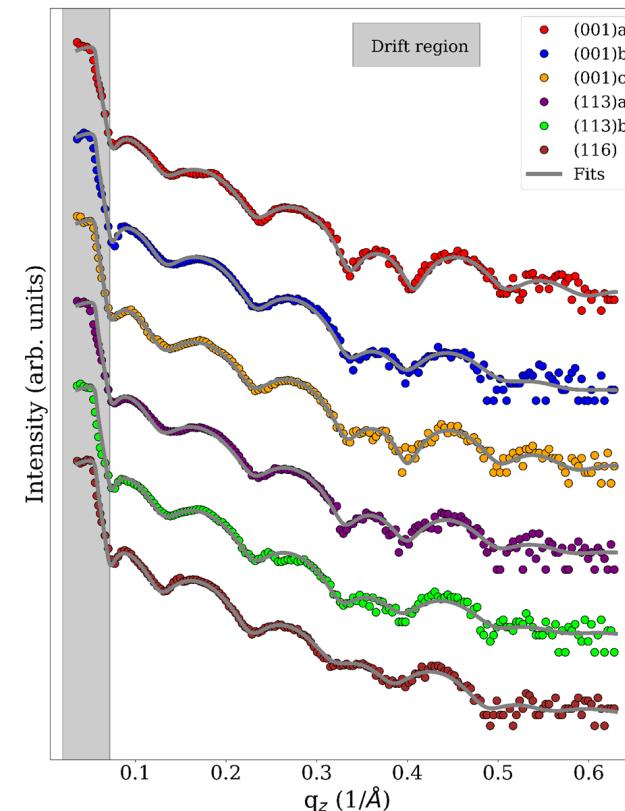
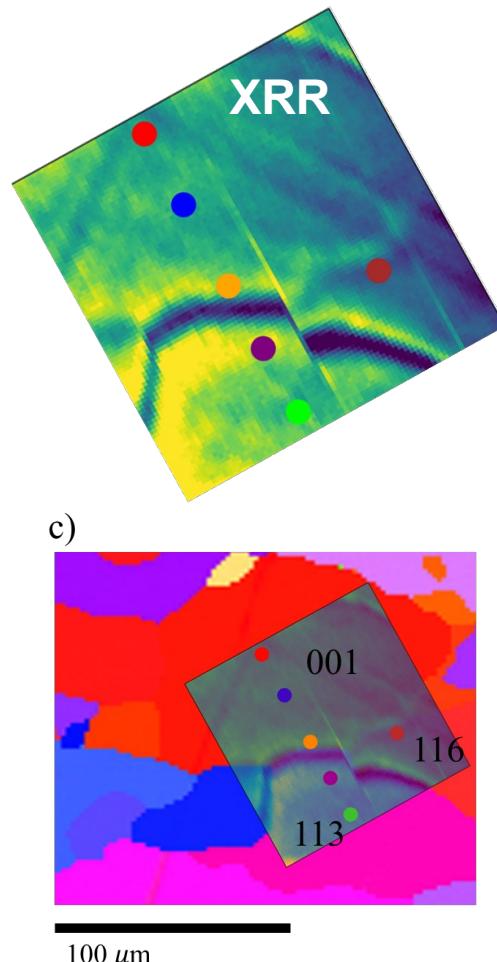
The Future: Surface Sensitive X-ray Diffraction with nm Resolution

First XRR experiments: ESRF ID1 on fine grain Nb foils for SC RF cavity applications

Photon energy 10 keV
70 nm X-ray beam size



HELMHOLTZ
ASSOCIATION



G. Dalla Lana, et al., in preparation

Thanks to:

DESY: The DESY NanoLab group, beamlines P07, P08, P09, P21, P22, P23, P24, P06, P01, P03, P10



KTH: Pan group

FZ Jülich: Schneider group

ESRF: ID1

FAU: Libuda group

Synchrotron sources for beamtime: PETRA III, ESRF

Financial support:



PETRA III



Thank You for Your Attention

